


<b>Search Notes</b>  	<b>Application/Control No.</b>  10016223	<b>Applicant(s)/Patent Under Reexamination</b>  CHANG ET AL.
	<b>Examiner</b>  AJAY BHATIA	<b>Art Unit</b>  2145

SEARCHED			
Class	Subclass	Date	Examiner
709	227	3/13/2008	AB
385	1.15 (see search)	3/13/2008	AB
455	557 (see search)	3/13/2008	AB

SEARCH NOTES		
Search Notes	Date	Examiner
East Search	3/13/2008	AB
Google Scholar	3/13/2008	AB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner